

Notice of References Cited	Application/Control No. 10/660,517	Applicant(s)/Patent Under Reexamination CHANG, SHU-MEI	
	Examiner Alan S. Chen	Art Unit 2182	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-2003/0163626 A1	08-2003	Chen et al.	710/305
	C	US-2004/0203415 A1	10-2004	Wu, Wen-Jen	455/066.1
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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